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Supporting Information

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Repurposing Poly(3-hexylthiophene) as a Conductivity-Reducing Additive for Polyethylene-Based High-Voltage Insulation

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Table S1. Effect of different types of conductivity-reducing additives on the DC conductivity of LDPE expressed in terms of the DC conductivity σ_{DC} of the additive-containing resin relative to the DC conductivity of the neat LDPE resin σ_{DC}^{PE} , and as the efficiency $\eta =$ $(\sigma_{DC}^{PE}/\sigma_{DC})/\phi$, where ϕ is the additive content in wt%. We limit our survey to DC conductivity measurements where the electric field was applied for at least 1 h, alhough values approaching the steady-state are only obtained for much longer measurements. ^aThe matrix is crosslinked LDPE (XLPE); ^bValues of the reported charging current in A.

Figure S1. Second heating DSC thermograms of neat LDPE and P3HT.

Figure S2. Second heating DSC thermograms of P3HT:LDPE blends.

C_{P3HT} 0.01 wt.%

Figure S3. Visual detection with a Kofler bench of melting of P3HT in a P3HT:LDPE blend c_{P3HT} = 0.01 wt%; sample thickness ~ 0.3 mm.

Figure S4. Polarized optical micrograph of a P3HT grain placed on top of a 30 μ m thick sheet of polyethylene, sandwiched between glass slides and heated for 2 min at 250 °C.

Figure S5. UV-Vis absorbance spectrum of a melt-pressed plaque of a blend with c_{P3HT} = 0.01 wt%; sample thickness \sim 1 mm.

According to standard Franck-Condon standard progression, the relative intensity of the vibronic replica is given by $^{[12]}$:

$$
I_{0\to m} \propto (\hbar \omega)^3 n_f^3 \frac{s^m e^{-s}}{m!}
$$
 (Eqn. 1)

where n_f is the refractive index at the given photon energy of $\hbar\omega$ at optical frequency of ω , *m* is the Franck−Condon vibronic index, and *S* is the Huang−Rhys factor. PL spectrum can be modeled as a modified Franck-Condon progression with a variable $0-0$ amplitude^[12]:

$$
I(\omega) \propto (\hbar \omega)^3 n_f^3 e^{-S} \times [(\alpha \Gamma(\hbar \omega - E_0) + \sum_{m=1}^{\infty} \frac{s^m}{m!} (\hbar \omega - (E_0 - mE_P))]
$$
(Eqn. 2)

where E_0 is the 0–0 transition energy, E_P is the phonon energy of the C=C symmetric stretch, *Γ* is the line-shape function (simplified to be purely Gaussian with a constant width), and α is a constant, known as relative intensity of 0–0 band. In above fitting, the parameters of *S*, *E^P* are kept constant and they are respectively, 1 and 0.18 eV. The fitted α and E_0 are obtained respetively, 0.52 ± 0.01 and 1.916 ± 0.002 , for the PL spectra of P3HT:LDPE blends with $c_{P3HT} = 0.1$ wt%.

Figure S6. PL spectrum of a melt-pressed plaque of a blend with $c_{P3HT} = 0.1$ wt% as well as a fit using the modified Franck-Condon model proposed by Spano et al.^[12-15] (red solid line); sample thickness ~ 0.1 mm.

Figure S7. High-voltage charging current of P3HT:LDPE blends at 70 °C. (a) the applied step-wise electric field and resulting current as a function of time, (b) charging current at the end of each 3 h step as a function of the applied electric field for samples measured with two different setups (with the same arrangments and electrode dimensions) as well as different processing protocols (melt-pressing of precipitated material vs. as-received pellets), (c) quasisteady-state charging current at the end of each 3 h step as a function of the applied electric field for blends with $c_{P3HT} = 0.0005$ -0.1 wt%.

Figure S8. High-voltage DC conductivities of P3HT:LDPE blends at 30 °C.

Figure S9. Space charge distribution in melt-pressed plaques of LDPE and P3HT:LDPE blends at 70 °C; PEA space charge distribution of film samples during charging (3 h, applied electric field of 50 kV mm^{-1}) and depolarization (1 h, removal of the electric field). The position of electrodes is shown as (-) and (+) for LDPE.

Figure S10. Space charge distribution of P3HT:LDPE blends with (a) $c_{P3HT} = 0.001$ wt% and (b) $c_{P3HT} = 0.01$ wt.% at 70 °C.

Figure S11. (a) PEA total charge (not net-charge) decay during 1 h discharging, (d) isothermal surface potential decay (ISPD) after charging of 0.1 mm thick melt-pressed plaques at 8 kV.

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